

N-CH40V Fast Switching MOSFETs

❖ GENERAL DESCRIPTION

The AMS4006 is the high cell density trenched N-ch MOSFETs, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The AMS4006 meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

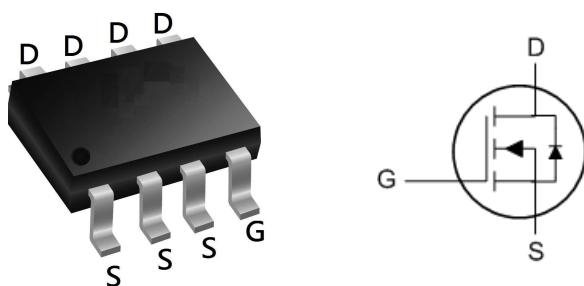
❖ FEATURES

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

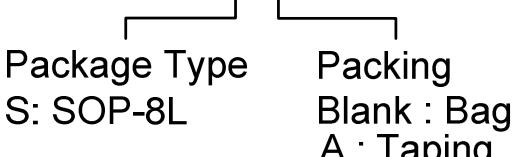
Product Summary

BVDSS	RDSON	ID
40V	7.5mΩ	10.5A

SOP8 Pin configuration



❖ ORDER/MARKING INFORMATION

Order Information	Top Marking
AMS4006 X X 	AM4006 → Part number YYWWX → ID code:internal YY: 01~26 (A~Z) 27~52 (a~z) → Year: 11=2011 12=2012 ... 19=2019

❖ ABSOLUTE MAXIMUM RATINGS

Characteristics	Symbol	Rating	Units
Drain-Source Voltage	V_{DS}	40	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current, $V_{GS} @ 10V$ (Note 1)	$I_D @ T_A = 25^\circ C$	10.5	A
Continuous Drain Current, $V_{GS} @ 10V$ (Note 1)	$I_D @ T_A = 70^\circ C$	8.4	A
Pulsed Drain Current (Note 2)	I_{DM}	42	A
Single Pulse Avalanche Energy (Note 3)	EAS	166	mJ
Avalanche Current	I_{AS}	39	A
Total Power Dissipation (Note 4)	$P_D @ T_A = 25^\circ C$	1.5	W
Storage Temperature Range	T_{STG}	-55 to 150	$^\circ C$
Operating Junction Temperature Range	T_J	-55 to 150	$^\circ C$
Thermal Resistance Junction-ambient (Steady State) (Note 1)	$R_{\theta JA}$	85	$^\circ C/W$
Thermal Resistance Junction-Case (Note 1)	$R_{\theta JC}$	28	$^\circ C/W$

Note 1: The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

Note 2: The data tested by pulsed, pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$

Note 3: The EAS data shows Max. rating. The test condition is $V_{DD}=25V$, $V_{GS}=10V$, $L=0.1mH$, $I_{AS}=39A$

Note 4: The power dissipation is limited by $150^\circ C$ junction temperature

Note 5: The Min. value is 100% EAS tested guarantee.

Note 6: The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

❖ ELECTRICAL CHARACTERISTICS

($T_J=25^\circ\text{C}$, unless otherwise noted)

Characteristics	Symbol	Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}$, $I_D=250\mu\text{A}$	40	-	-	V
BVDSS Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Reference to 25°C , $I_D=1\text{mA}$	-	0.034	-	$\text{V}/^\circ\text{C}$
Static Drain-Source On-Resistance (Note 2)	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}$, $I_D=10\text{A}$	-	6	7.5	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}$, $I_D=8\text{A}$	-	8	10	
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}}=V_{\text{DS}}$, $I_D=250\mu\text{A}$	1.0	1.5	2.5	V
$V_{\text{GS}(\text{th})}$ Temperature Coefficient	$\Delta V_{\text{GS}(\text{th})}$		-	-4.96	-	$\text{mV}/^\circ\text{C}$
Drain-Source Leakage Current	I_{DSS}	$V_{\text{DS}}=32\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	-	-	1	μA
		$V_{\text{DS}}=32\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=55^\circ\text{C}$	-	-	5	
Gate-Source Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Forward Transconductance	g_{fs}	$V_{\text{DS}}=5\text{V}$, $I_D=10\text{A}$	-	40	-	S
Gate Resistance	R_g	$V_{\text{DS}}=0\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	-	1.6	3.2	Ω
Total Gate Charge (4.5V)	Q_g	$V_{\text{DS}}=20\text{V}$, $V_{\text{GS}}=4.5\text{V}$, $I_D=10\text{A}$	-	18.8	-	nC
Gate-Source Charge	Q_{gs}		-	4.7	-	
Gate-Drain Charge	Q_{gd}		-	8.2	-	
Turn-On Delay Time	$T_{\text{d}(\text{on})}$	$V_{\text{DD}}=15\text{V}$, $V_{\text{GS}}=10\text{V}$, $R_G=3.3\Omega$ $I_D=1\text{A}$	-	14.3	-	ns
Rise Time	T_r		-	2.6	-	
Turn-Off Delay Time	$T_{\text{d}(\text{off})}$		-	77	-	
Fall Time	T_f		-	4.8	-	
Input Capacitance	C_{iss}	$V_{\text{DS}}=15\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	-	2332	-	pF
Output Capacitance	C_{oss}		-	193	-	
Reverse Transfer Capacitance	C_{rss}		-	138	-	
Guaranteed Avalanche Characteristics						
Single Pulse Avalanche Energy (Note 5)	EAS	$V_{\text{DD}}=25\text{V}$, $L=0.1\text{mH}$, $I_{\text{AS}}=24\text{A}$	63	-	-	mJ
Diode Characteristics						
Continuous Source Current (Note 1, 6)	I_s	$V_G=V_D=0\text{V}$, Force Current	-	-	10.5	A
Pulsed Source Current (Note 2, 6)	I_{SM}		-	-	42	A
Diode Forward Voltage (Note 2)	V_{SD}	$V_{\text{GS}}=0\text{V}$, $I_s=1\text{A}$, $T_J=25^\circ\text{C}$	-	-	1	V

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Note 2: The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$

Note 3: The EAS data shows Max. rating. The test condition is $V_{\text{DD}}=25\text{V}$, $V_{\text{GS}}=10\text{V}$, $L=0.1\text{mH}$, $I_{\text{AS}}=39\text{A}$

Note 4: The power dissipation is limited by 150°C junction temperature

Note 5: The Min. value is 100% EAS tested guarantee.

Note 6: The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

❖ TYPICAL CHARACTERISTICS

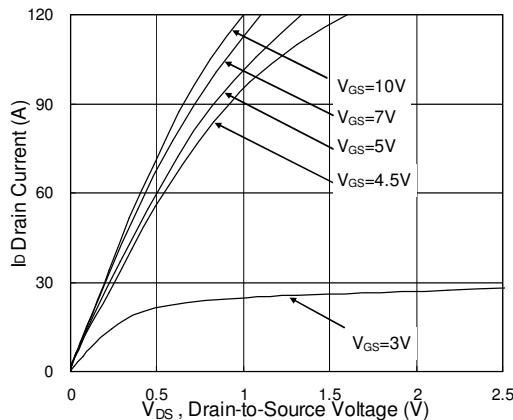


Fig.1 Typical Output Characteristics

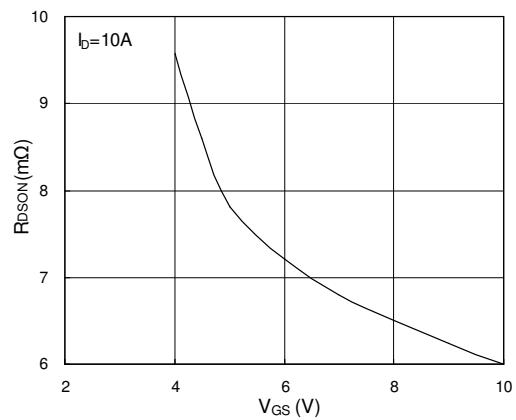


Fig.2 On-Resistance vs. G-S Voltage

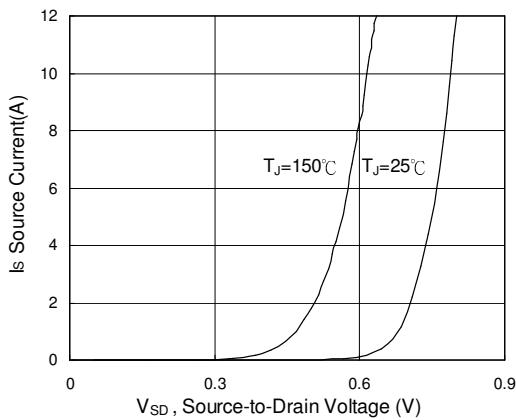


Fig.3 Forward Characteristics of Reverse

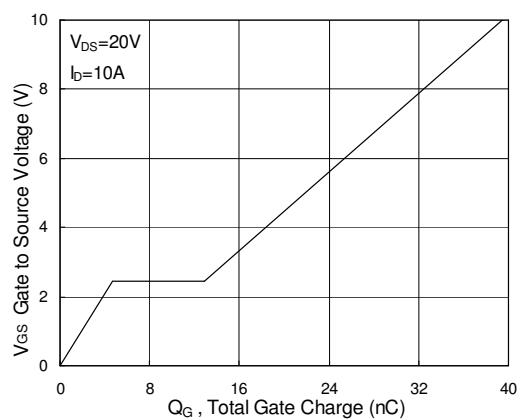


Fig.4 Gate-Charge Characteristics

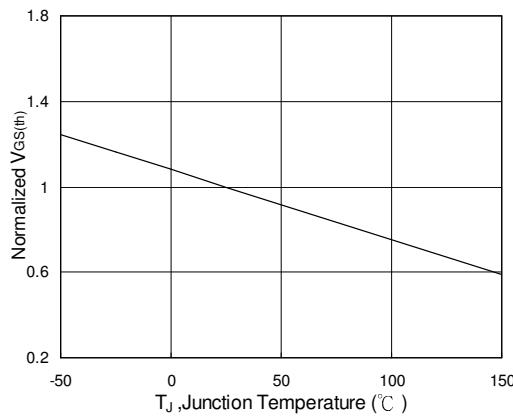


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

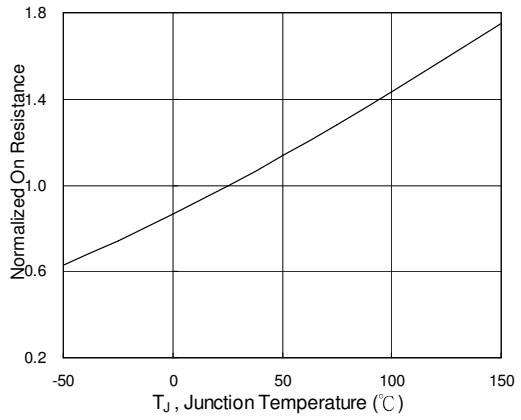


Fig.6 Normalized R_{DSON} vs. T_J

❖ TYPICAL CHARACTERISTICS (CONTINUOUS)

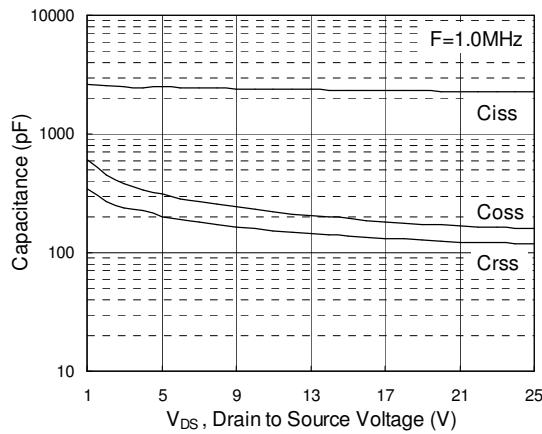


Fig.7 Capacitance

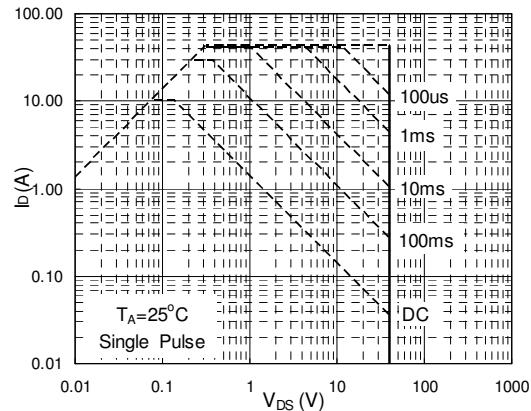


Fig.8 Safe Operating Area

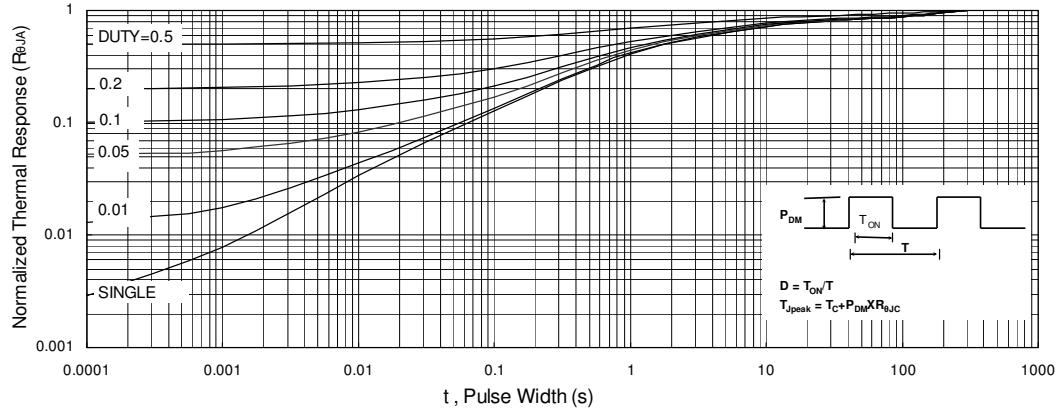


Fig.9 Normalized Maximum Transient Thermal Impedance

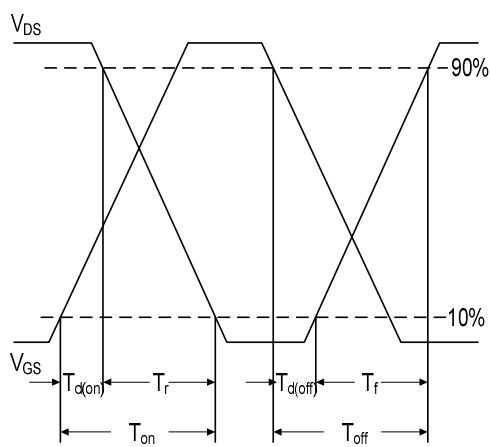


Fig.10 Switching Time Waveform

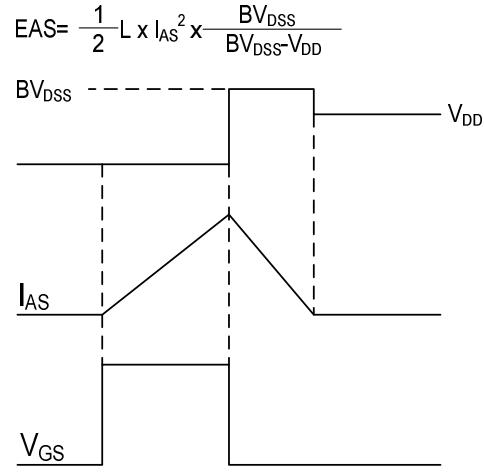


Fig.11 Unclamped Inductive Switching Waveform